

MILITARY SPECIFICATION

SEMICONDUCTOR DEVICE, TRANSISTOR, PNP, GERMANIUM, SWITCHING
TYPE 2N3449

This amendment forms a part of Military Specification
MIL-S-19500/338(USAF), dated 29 September 1965.

PAGE 1

- * Bottom right hand corner: Delete FSC 5960" and substitute FSC 5961".

PAGE 5

- * 4.2, delete and substitute:

"4.2 Qualitication inspection. Qualification inspection is not required."

- * 4.3.1, delete and substitute:

"4.3.1 Group A inspection. Group A inspection shall consist of the examinations and tests specified in table I on a 100% basis."

PAGES 6 AND 7

- * TABLE I: Delete LTPD column.

PAGE 8

TABLE II, subgroups 2,3, and 5, method 3036: Delete "Bias condition C" and substitute "Bias condition D".

PAGE 10

TABLE III, subgroup 1, method 3036: Delete " $I_B = 0$ " and substitute " $I_E = 0$ ".

TABLE III, max column under limits: Delete "100" and substitute "-100".

NOTE: The margins of this amendment is marked with an asterisk to indicate where a change from the previous amendment was made. This is done as a convenience only and the Government assumes no liability whatsoever for any inaccuracies in these notations. Bidders and contractors are cautioned to evaluate the requirements of this document based on the entire content irrespective of the marginal notations and relationship to the previous amendment.

Custodian:
Air Force - 17

Review activities:
Air Force - 85
DLA - ES

Preparing activity:
Air Force - 17

Agent:
DLA - ES

(Project 5961-F793)